



**SEMITRANS® 2**

## Superfast NPT-IGBT Module

**SKM 100GB063D**

### Features

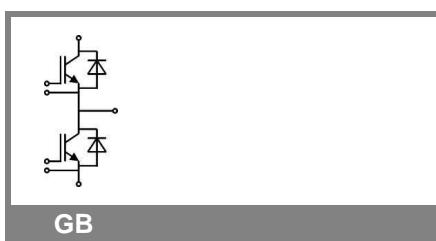
- N channel, homogeneous Silicon structure (NPT- Non punch through IGBT)
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of  $V_{CEsat}$
- Very low  $C_{ies}$ ,  $C_{oes}$ ,  $C_{res}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper Bonding Technology without hard mould
- Large clearance (10 mm) and creepage distances (20 mm)

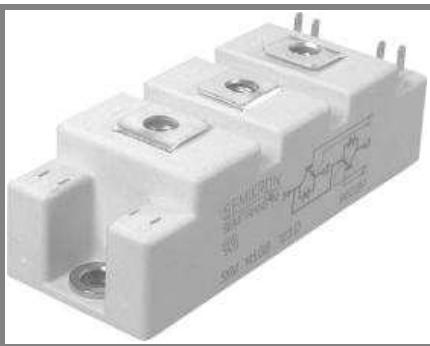
### Typical Applications\*

- Switching (not for linear use)
- Switched mode power supplies
- UPS
- Three phase inverters for servo / AC motor speed control
- Pulse frequencies also above 10 kHz

Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$	$T_j = 25^\circ\text{C}$	600		V
$I_C$	$T_j = 150^\circ\text{C}$ $T_{case} = 25^\circ\text{C}$ $T_{case} = 70^\circ\text{C}$	130 100	A A	
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	200		A
$V_{GES}$		$\pm 20$		V
$t_{psc}$	$V_{CC} = 300\text{ V}$ ; $V_{GE} \leq 20\text{ V}$ ; $T_j = 125^\circ\text{C}$ $V_{CES} < 600\text{ V}$	10		$\mu\text{s}$
<b>Inverse Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$ $T_{case} = 25^\circ\text{C}$ $T_{case} = 80^\circ\text{C}$	100 75	A A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	200		A
$I_{FSM}$	$t_p = 10\text{ ms}$ ; sin. $T_j = 150^\circ\text{C}$	720		A
<b>Module</b>				
$I_{t(RMS)}$		200		A
$T_{vj}$		- 40 ... + 150		$^\circ\text{C}$
$T_{stg}$		- 40 ... + 125		$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500		V

Characteristics		$T_c = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	min.	typ.	max.
<b>IGBT</b>				
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 2\text{ mA}$	4,5	5,5	6,5
$I_{CES}$	$V_{GE} = 0\text{ V}$ , $V_{CE} = V_{CES}$ $T_j = 25^\circ\text{C}$	0,1	0,3	mA
$V_{CEO}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	1,05 1		V
$r_{CE}$	$V_{GE} = 15\text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	10,5 14		$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 100\text{ A}$ , $V_{GE} = 15\text{ V}$ $T_j = 25^\circ\text{C}_{chiplev.}$ $T_j = 125^\circ\text{C}_{chiplev.}$	2,1 2,4	2,5 2,8	V
$C_{ies}$ $C_{oes}$ $C_{res}$	$V_{CE} = 25\text{ V}$ , $V_{GE} = 0\text{ V}$ $f = 1\text{ MHz}$	5,6 0,6 0,4		nF
$Q_G$	$V_{GE} = 0\text{ V} - +15\text{ V}$	240		nC
$R_{Gint}$	$T_j = \text{ }^\circ\text{C}$	0		$\Omega$
$t_{d(on)}$ $t_r$ $E_{on}$	$R_{Gon} = 10\text{ }\Omega$	50 40 4		ns ns mJ
$t_{d(off)}$ $t_f$ $E_{off}$	$R_{Goff} = 10\text{ }\Omega$ $T_j = 125^\circ\text{C}$ $V_{GE} = \pm 15\text{ V}$	300 35 3		ns ns mJ
$R_{th(j-c)}$	per IGBT	0,27		K/W





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Symbol	Conditions	min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 100 \text{ A}; V_{GE} = 0 \text{ V}$ $T_j = 25^\circ\text{C}_{\text{chiplev.}}$ $T_j = 125^\circ\text{C}_{\text{chiplev.}}$		1,55 1,55	1,9	V V
$V_{FO}$	$T_j = 125^\circ\text{C}$			0,9	V
$r_F$	$T_j = 125^\circ\text{C}$		8	10	$\text{m}\Omega$
$I_{RRM}$ $Q_{rr}$ $E_{rr}$	$I_F = 100 \text{ A}$ $T_j = 125^\circ\text{C}$ $V_{GE} = -15 \text{ V}; V_{CC} = 300 \text{ V}$		44 6		A $\mu\text{C}$ $\text{mJ}$
$R_{th(j-c)D}$	per diode			0,6	K/W
<b>Module</b>					
$L_{CE}$				30	nH
$R_{CC'EE'}$	res., terminal-chip $T_{case} = 25^\circ\text{C}$ $T_{case} = 125^\circ\text{C}$		0,75 1		$\text{m}\Omega$ $\text{m}\Omega$
$R_{th(c-s)}$	per module			0,05	K/W
$M_s$	to heat sink M6		3	5	Nm
$M_t$	to terminals M5		2,5	5	Nm
w				160	g

## Features

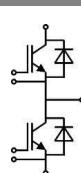
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- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of  $V_{CEsat}$
- Very low  $C_{ies}$ ,  $C_{oes}$ ,  $C_{res}$
- Latch-up free
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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

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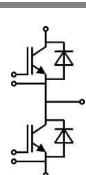
<b>Z<sub>th</sub></b> <b>Symbol</b>	<b>Conditions</b>	<b>Values</b>	<b>Units</b>
<b>Z<sub>th(j-c)I</sub></b>			
R <sub>i</sub>	i = 1	160	mk/W
R <sub>i</sub>	i = 2	88	mk/W
R <sub>i</sub>	i = 3	18	mk/W
R <sub>i</sub>	i = 4	4	mk/W
tau <sub>i</sub>	i = 1	0,0447	s
tau <sub>i</sub>	i = 2	0,0087	s
tau <sub>i</sub>	i = 3	0,0015	s
tau <sub>i</sub>	i = 4	0,0002	s
<b>Z<sub>th(j-c)D</sub></b>			
R <sub>i</sub>	i = 1	400	mk/W
R <sub>i</sub>	i = 2	165	mk/W
R <sub>i</sub>	i = 3	30,5	mk/W
R <sub>i</sub>	i = 4	4,5	mk/W
tau <sub>i</sub>	i = 1	0,0613	s
tau <sub>i</sub>	i = 2	0,0085	s
tau <sub>i</sub>	i = 3	0,0045	s
tau <sub>i</sub>	i = 4	0,0003	s

## Features

- N channel, homogeneous Silicon structure (NPT- Non punch through IGBT)
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of V<sub>CEsat</sub>
- Very low C<sub>ies</sub>, C<sub>oes</sub>, C<sub>res</sub>
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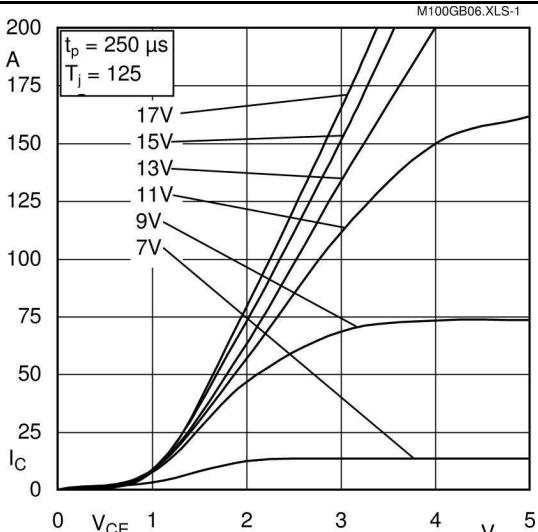


Fig. 1 Typ. output characteristic, inclusive  $R_{CC} + EE'$

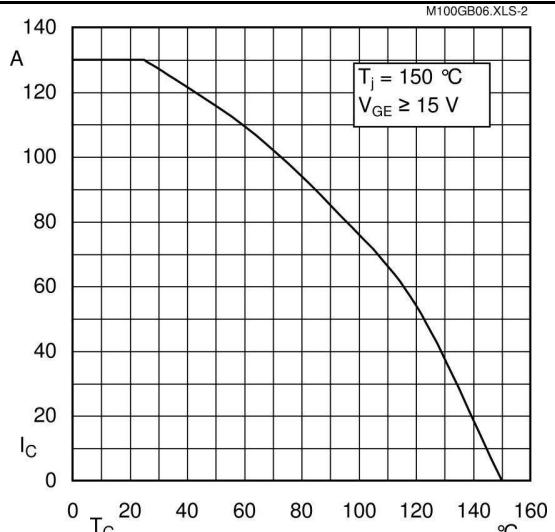


Fig. 2 Rated current vs. temperature  $I_C = f(T_C)$

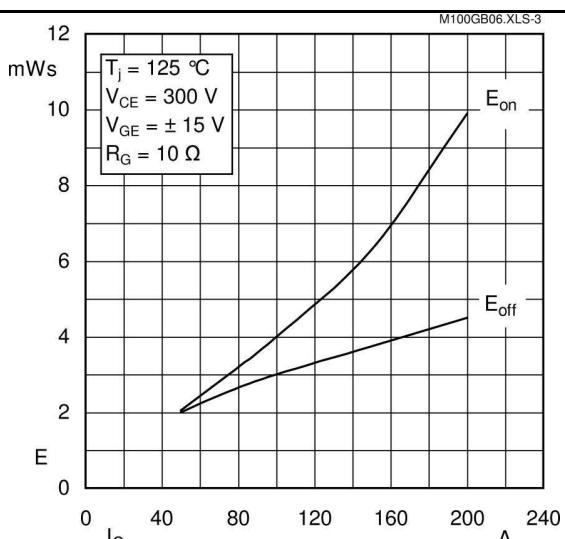


Fig. 3 Typ. turn-on /-off energy =  $f(I_C)$

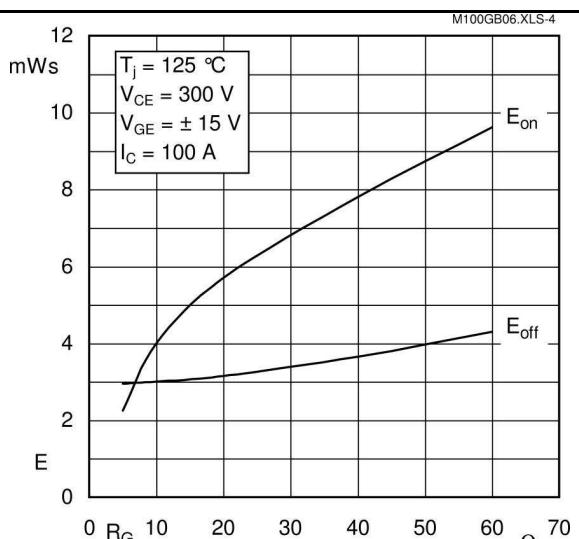


Fig. 4 Typ. turn-on /-off energy =  $f(R_G)$

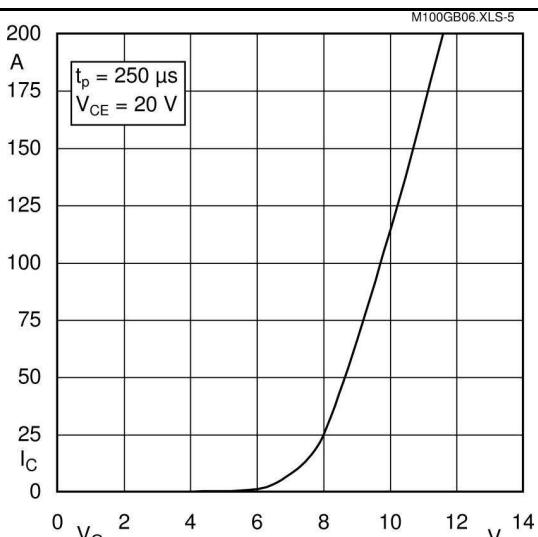


Fig. 5 Typ. transfer characteristic

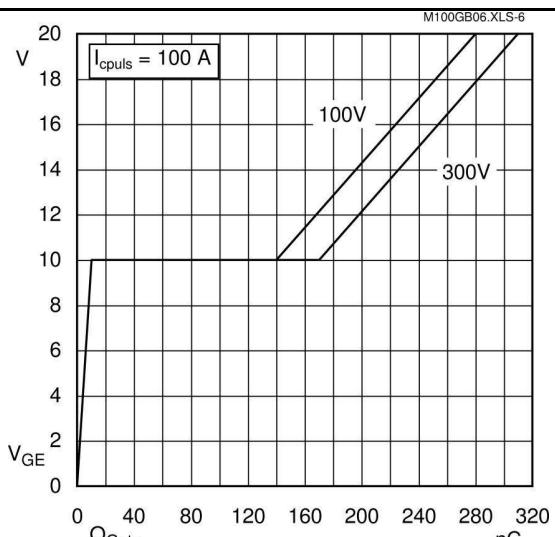


Fig. 6 Typ. gate charge characteristic

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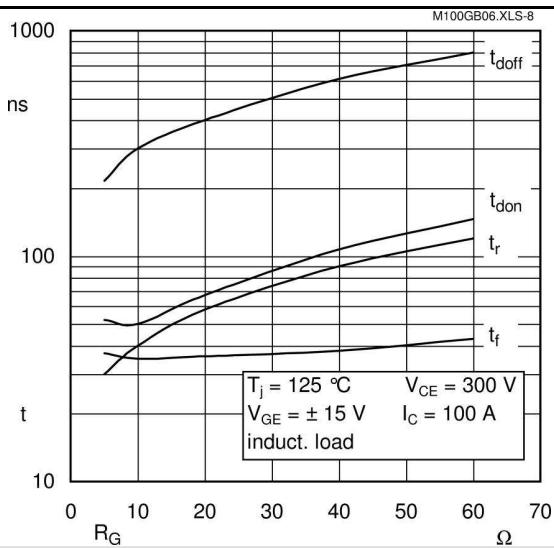


Fig. 7 Typ. switching times vs.  $I_C$

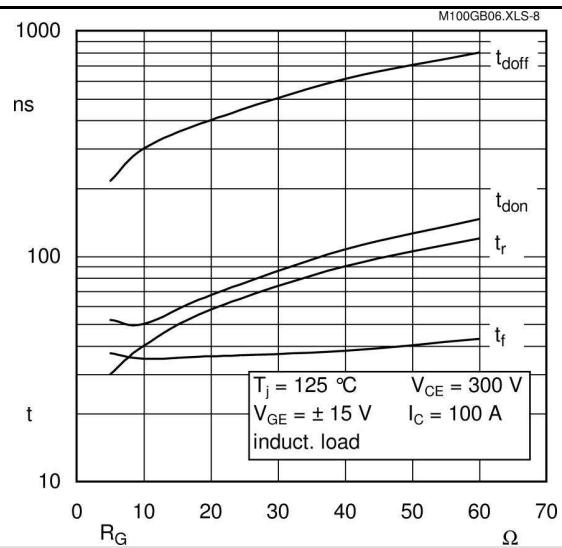


Fig. 8 Typ. switching times vs. gate resistor  $R_G$

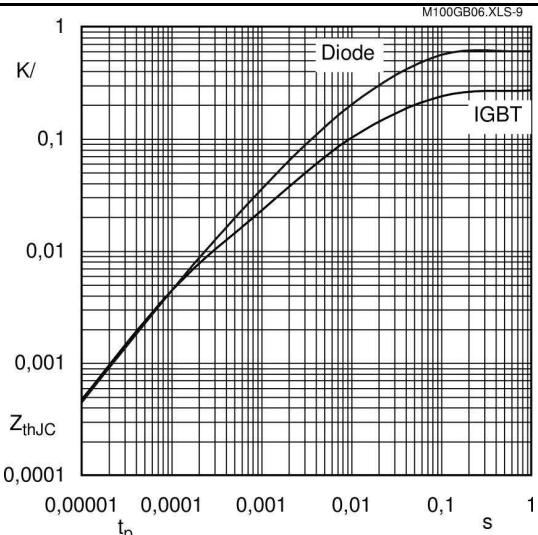


Fig. 9 Transient thermal impedance of IGBT and Diode

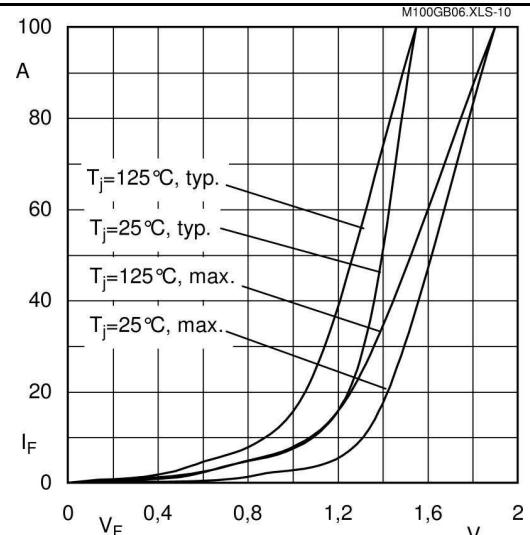


Fig. 10 CAL diode forward characteristic

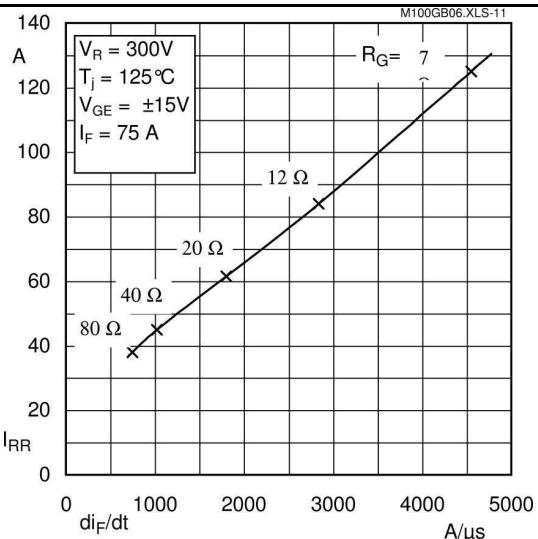


Fig. 11 Typ. CAL diode peak reverse recovery current

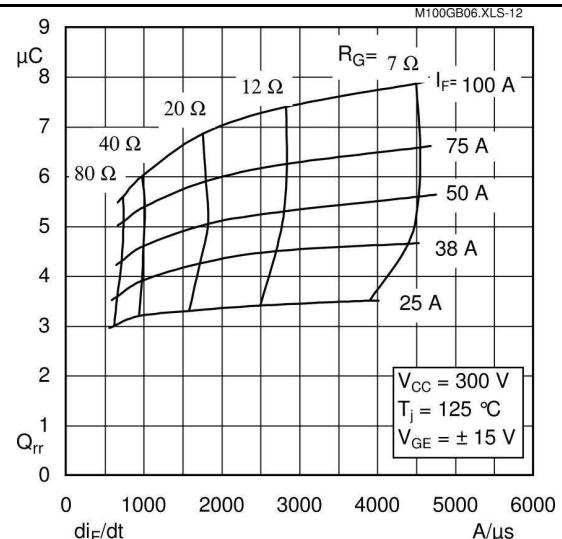


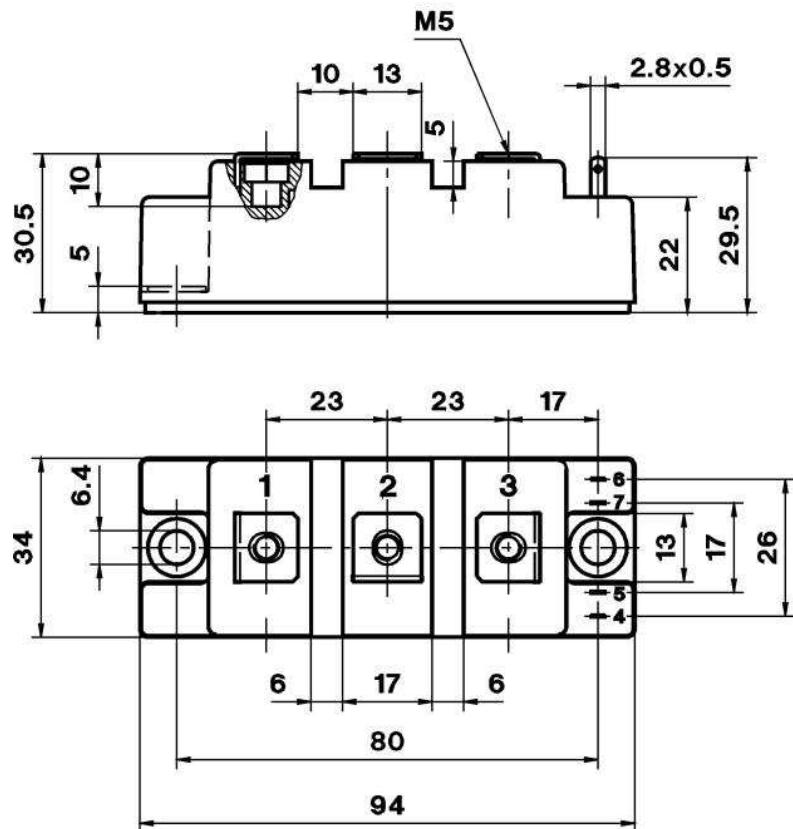
Fig. 12 Typ. CAL diode recovered charge

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UL recognized file

no. E 63 532

CASED61



Case D 61

